

Notice of References Cited	Application/Control No. 10/791,815	Applicant(s)/Patent Under Reexamination FUJISAWA ET AL.	
	Examiner David Buttner	Art Unit 1712	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0235588	11-2004	Fujisawa et al.	473/378
*	B	US-5,300,257	04-1994	Akashi et al.	252/400.24
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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